

**Search Notes**

Application/Control No.

10/662,596

Examiner

DINH T. LE

Applicant(s)/Patent under  
Reexamination

CHO ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	156-158, 147-149	5/1/2006	DL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(Attached a search copy)	5/1/2006	DL